


<b>Search Notes</b> 	<b>Application/Control No.</b> 10590339	<b>Applicant(s)/Patent Under Reexamination</b> SHIN ET AL.
	<b>Examiner</b> David Phantana-angkool	<b>Art Unit</b> 2175

SEARCHED			
Class	Subclass	Date	Examiner
715	400, 825	6/5/2009	DP

SEARCH NOTES		
Search Notes	Date	Examiner
EAST -(see attached)	11/19/2008	DP
UPDATE SEARCH	6/5/2009	DP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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